

A LOW-COST, RECONFIGURABLE THIN- FILM INSPECTION SYSTEM

TOWARDS LARGE AREA THIN-FILM REFLECTOMETRY

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A LOW-COST, RECONFIGURABLE THIN-FILM INSPECTION
SYSTEM

OVERVIEW THIN-FILMS

- What are Thin Films?
- Motivation
 - Challenges
- State of the Art
- Approach
- Status
- Future work

$$T \pm 1nm$$



min: 2 nm;
max: 150 nm

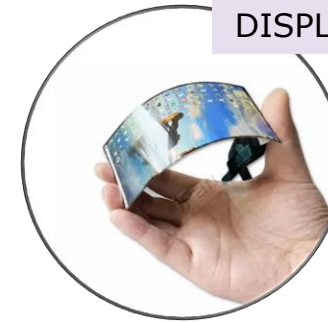
For Reference, A single strand of human hair is approximately 60,000 to 120,000 nm wide



BATTERY CELLS



DISPLAYS



FOOD PACKAGING



SOLAR CELLS



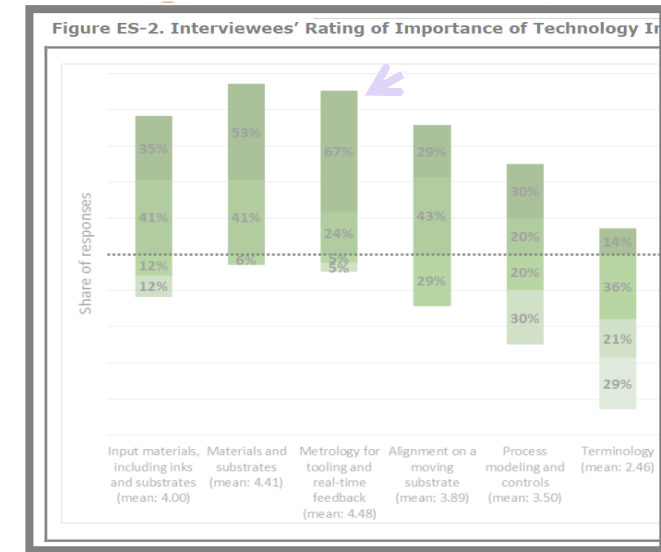
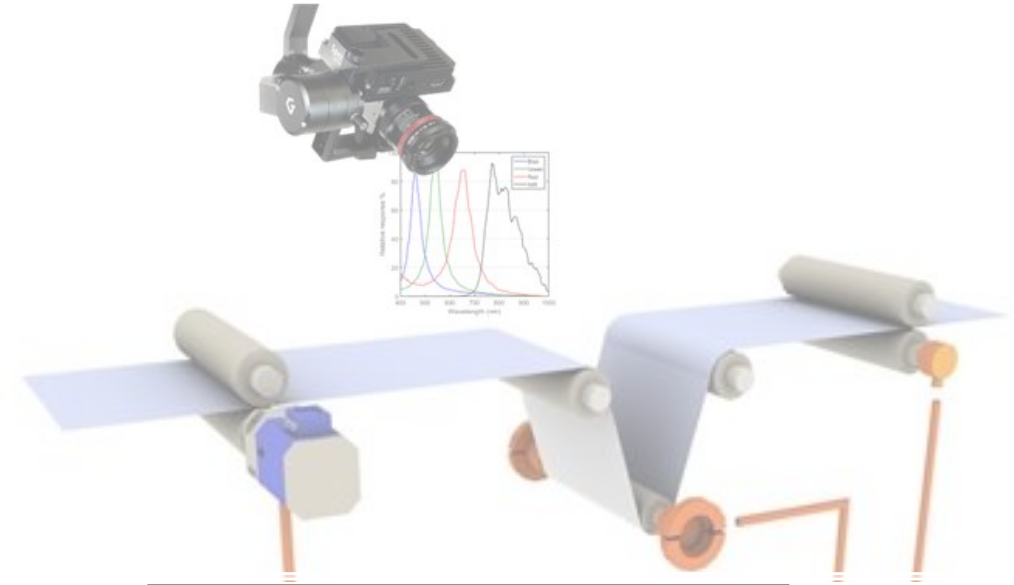
ILLUSTRATION OF INDUSTRIAL THIN-FILM INSPECTION

MOTIVATION

- “Metrology has not kept up with thin-film manufacturing speeds” (Maize et al, 2022; NIST 2016)
- Large-area thin films are everywhere!
 - used in PV, displays, batteries, and packaging
- Industry often needs 100% inline, real-time inspection

CHALLENGES

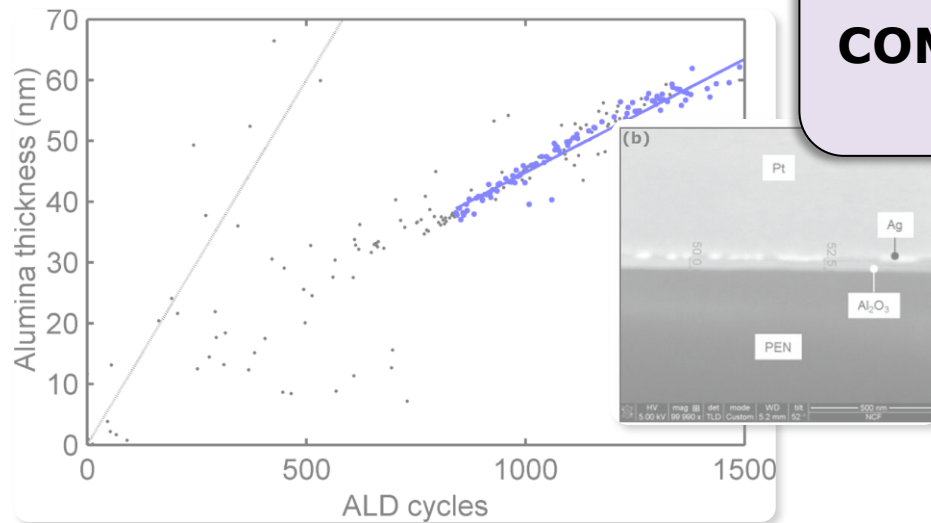
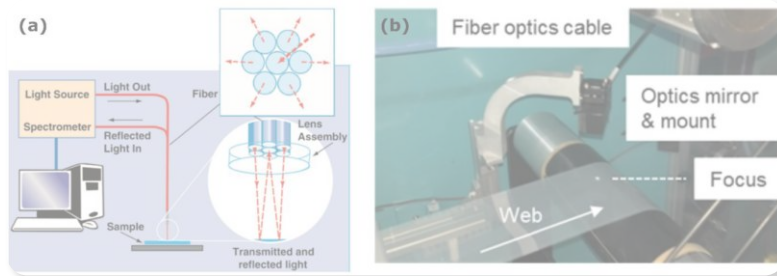
- Metrology is too computationally heavy or too slow
- Also, too expensive



IMPORTANCE OF METROLOGY IN R2R MANUFACTURING

STATE OF THE ART

POINT THIN FILM INSPECTION

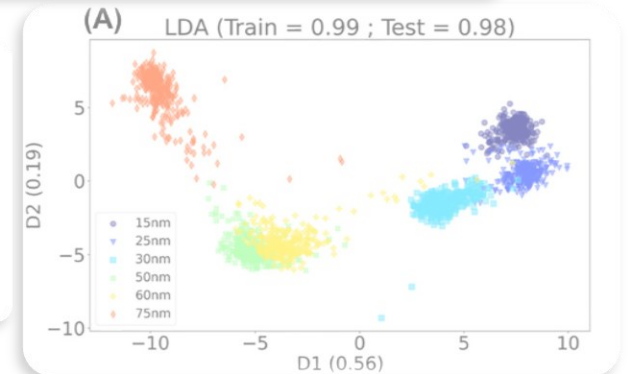
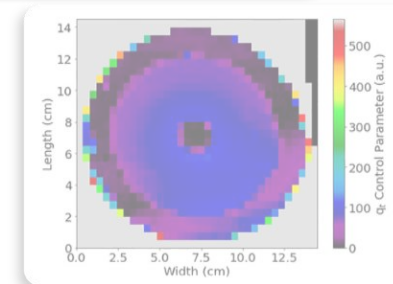
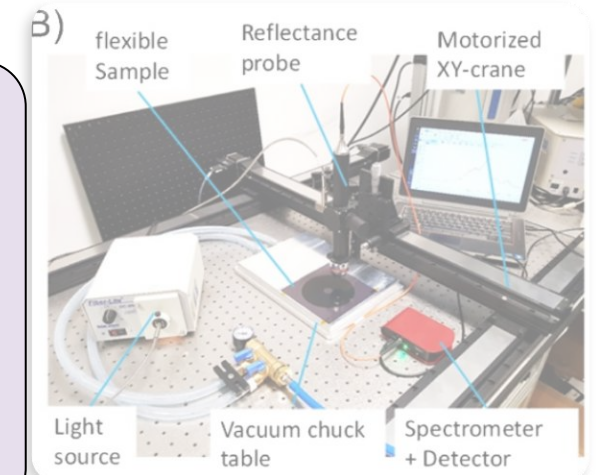


FOR 52NM ALD MOVING AT 1M/S Al_2O_3 (2014)

ALL USE **FULL REFLECTANCE SPECTRA (HYPERSPSCTRAL)**

WHICH CAN BE **COMPUTATIONALLY HEAVY and COSTLY**

AREA MAPPING INSPECTION

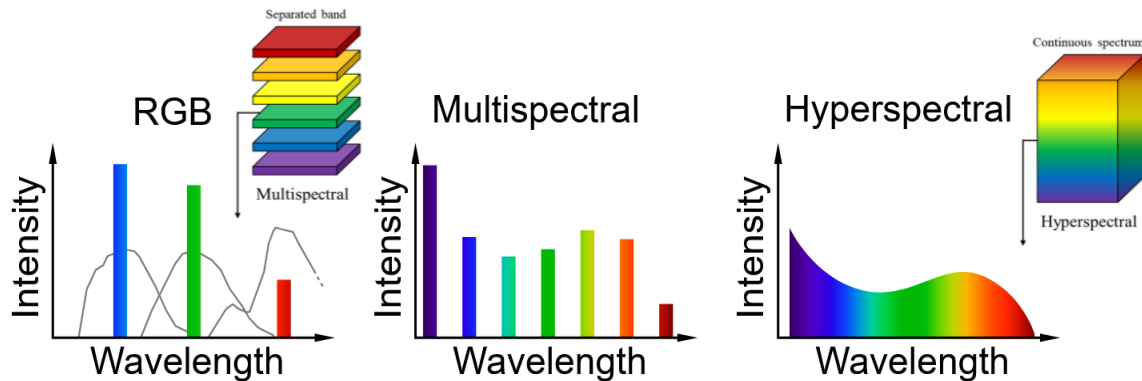


25NM Al_xO FILM ON SILICON, (ENRIC, 2021)

BACKGROUND

Multispectral and RGB Cameras have **less spectral resolution**

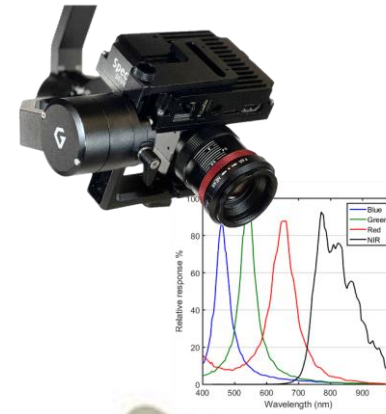
- Each pixel adds spectral/color data
- **3 channels for RGB, ~1000 for Hyperspectral**



REDUCED SPECTRAL RESOLUTION WITH HYPERSPECTRAL

APPROACH

- Use multispectral/RGB cameras instead.



- Less computation = Fast!
(3 Channels vs 1000 Channels)
- Less expensive!
(\$300 vs \$100,000)

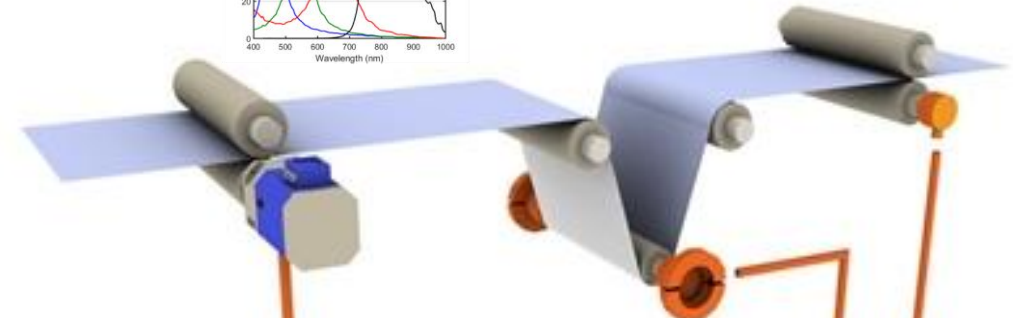
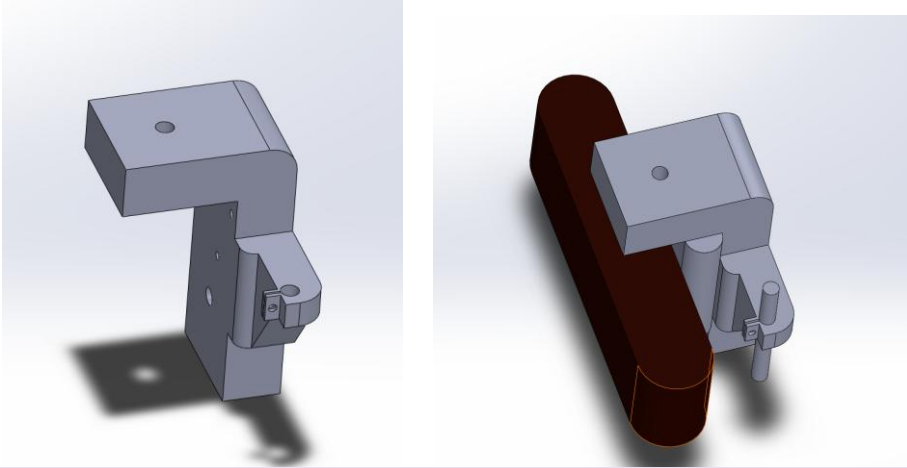


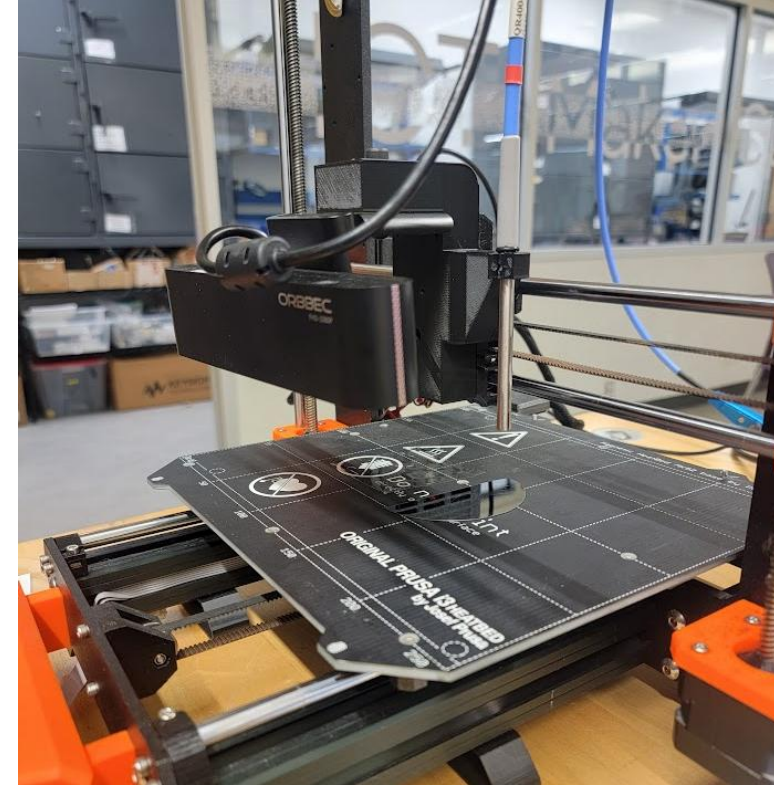
ILLUSTRATION OF INDUSTRIAL THIN-FILM INSPECTION

APPROACH – GANTRY DESIGN

- Prusa 3D MK3s was adapted to create an operational gantry
- A rig was designed and built to attach camera and spectrometer to the gantry



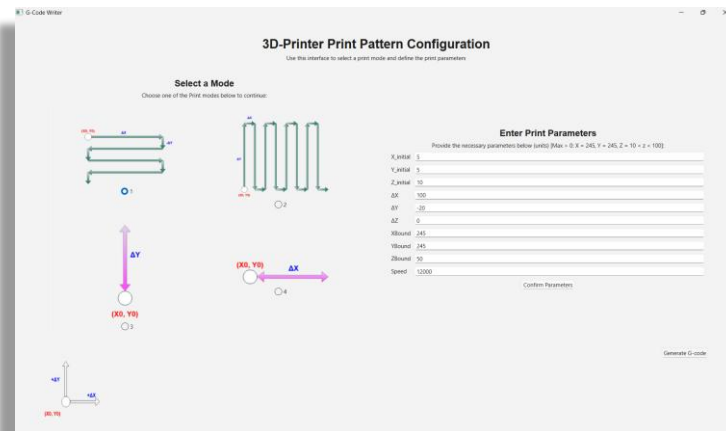
3D CAD OF CAMERA AND SPECTROMETER JIG



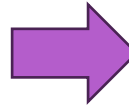
PICTURE OF ASSEMBLED SYSTEM

APPROACH - USER INTERFACE

- A user interface was built to turn user instruction into machine procedure

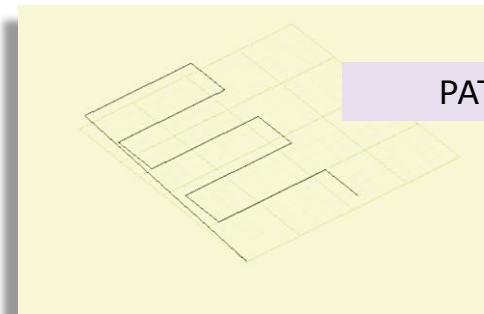
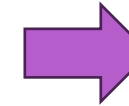


USER INTERFACE

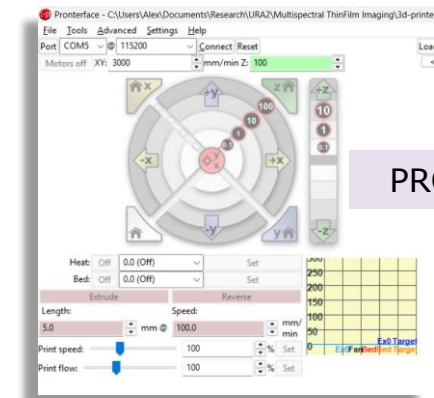


```
3d-printer_scan_pattern_output.tx
File Edit View
G21
G90
G1 X5 Y200 Z10 F12000
G1 X105 F12000
G1 Y160 F12000
G1 X5 F12000
G1 Y120 F12000
G1 X105 F12000
G1 Y80 F12000
G1 X5 F12000
G1 Y40 F12000
G1 X105 F12000
G1 Y0 F12000
```

G-CODE



PATH

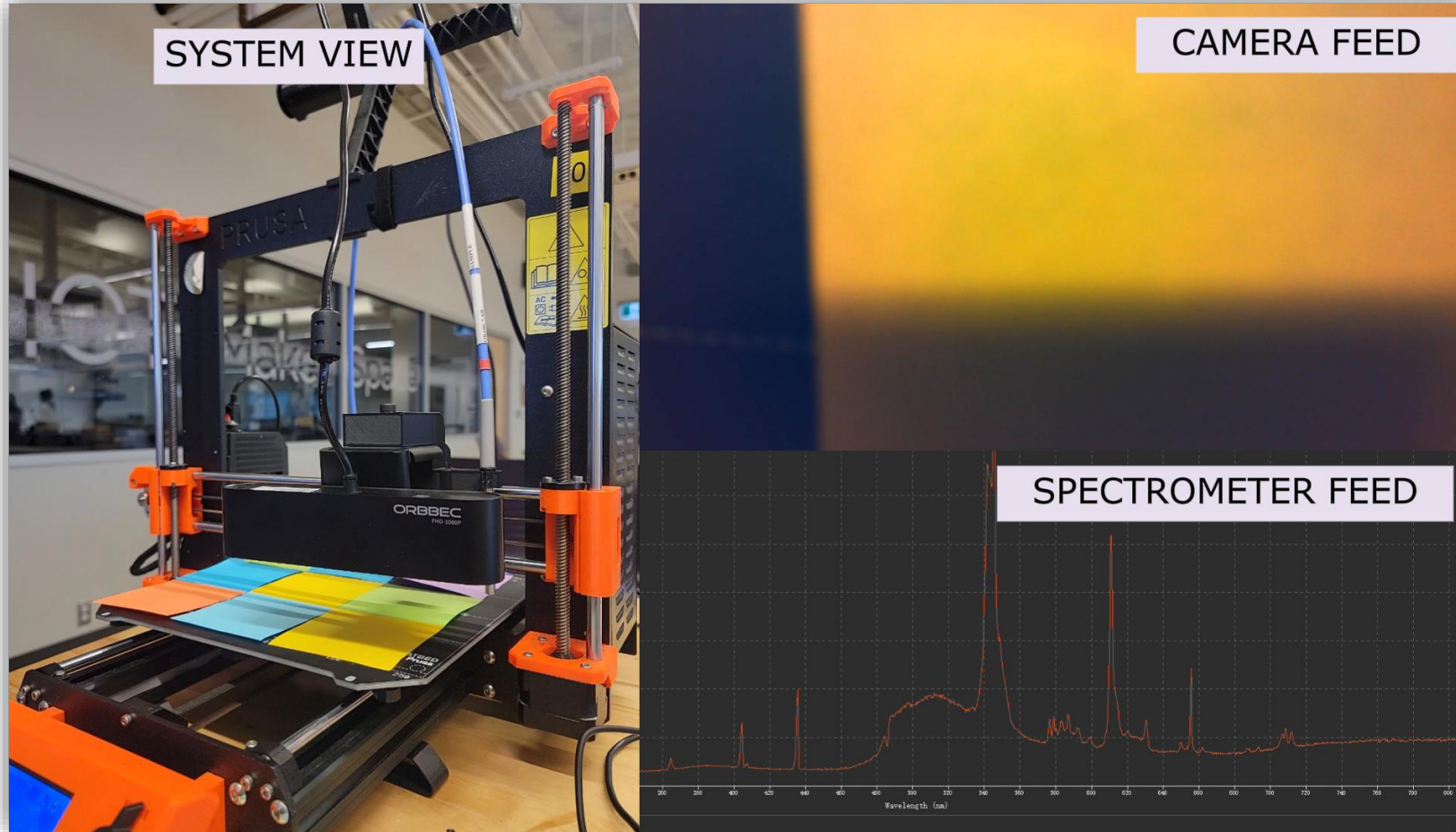


PRONTERFACE

Loading file: C:\Users\Alex\Documents\Research\URA2\Multispectral ThinFilm Imaging\3d-printer_scan_pattern_output.txt
Loaded C:\Users\Alex\Documents\Research\URA2\Multispectral ThinFilm Imaging\3d-printer_scan_pattern_output.txt, 13 lines
0.00mm of filament used in this print
The print goes:
- from 5.00 mm to 105.00 mm in X and is 100 wide
- from 0.00 mm to 200.00 mm in Y and is 200.00 mm deep
- from 0.00 mm to 10.00 mm in Z and is 10.00 mm high
Estimated duration: 1 layers, 0:00:05

MACHINE CODE

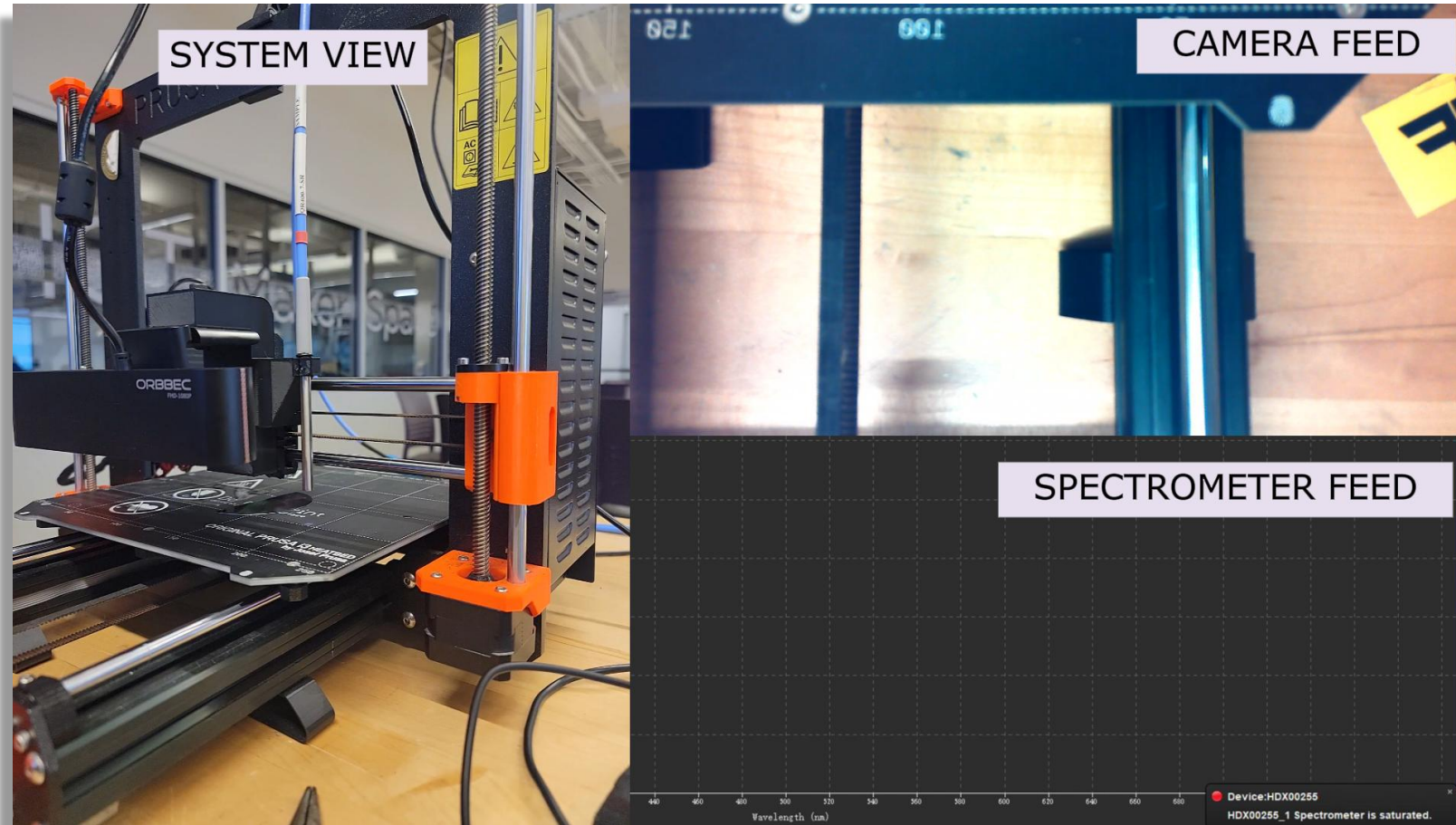
STICKY NOTE TEST!



- Simultaneously capture full spectrum and 3-channel spectrum
- Can analyze spectra to extract thickness

CAPTURE OF STICKY NOTE ARRAY

SAMPLE TEST!

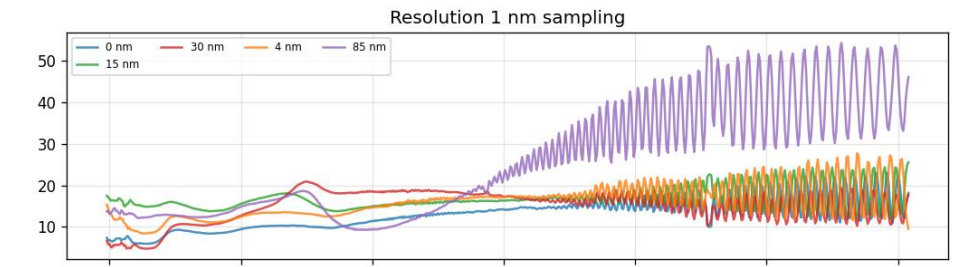
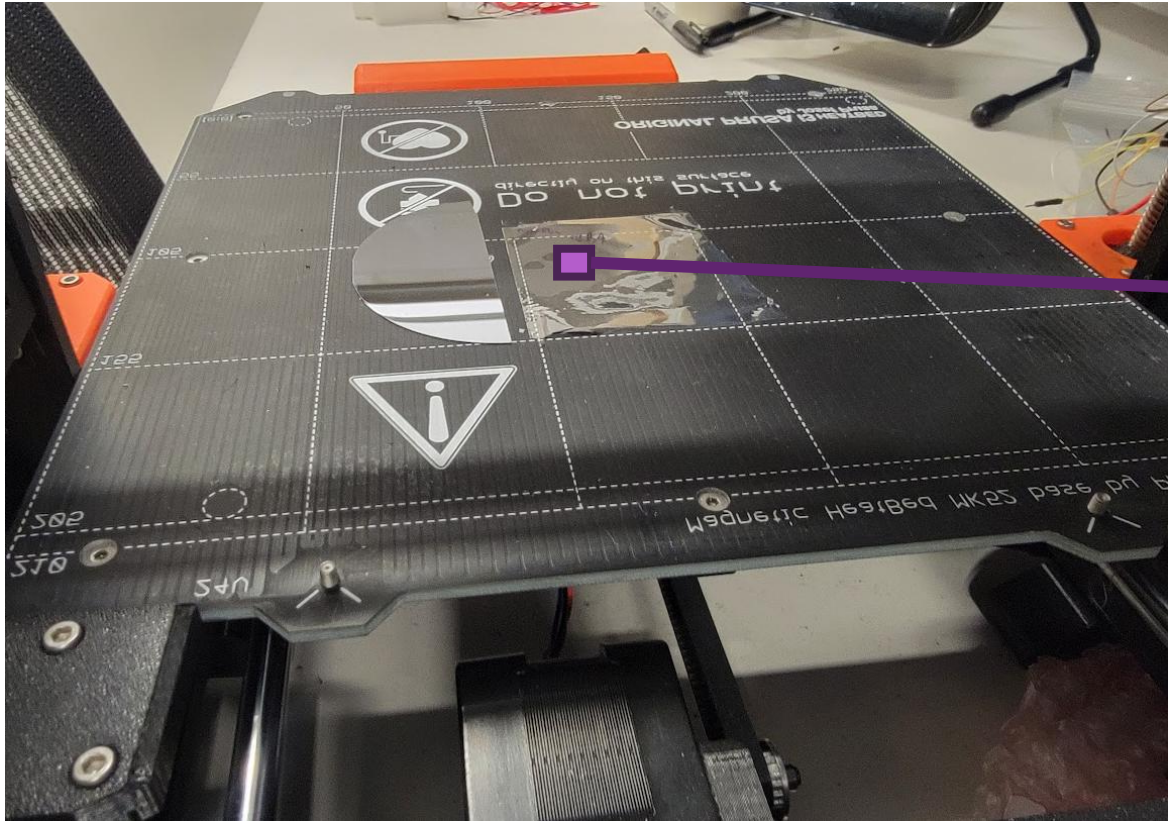


- Simultaneously capture full spectrum and 3-channel spectrum
- Can analyze spectra to extract thickness

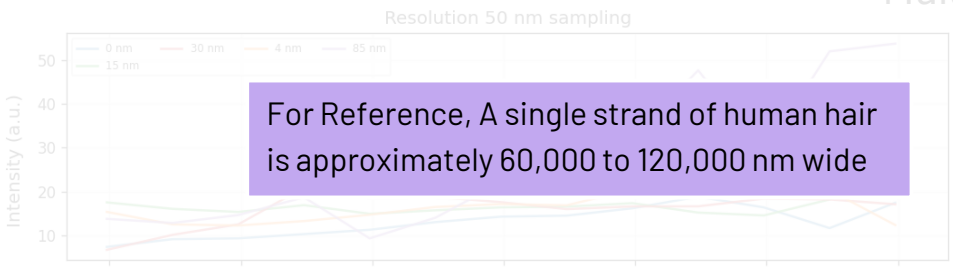
CAPTURE OF SILICON WAFER AND PLA SHEET

PRELIMINARY ANALYSIS

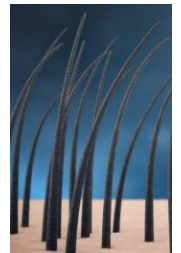
Spectrometer



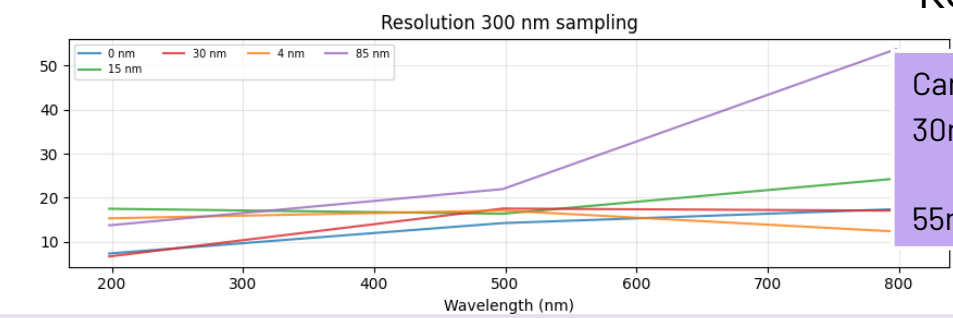
Multispectral



For Reference, A single strand of human hair is approximately 60,000 to 120,000 nm wide



RGB



Can see 85nm vs 30nm!
55nm difference!

IMAGES OF SAMPLE ON STAGE

SPECTRAL RESOLUTION REDUCED BY BINNING AND AVERAGING

FUTURE WORK

- Improve UI and Camera rig
- Test on more samples (from partners)
- Increase metrology accuracy
- Integrate into real system

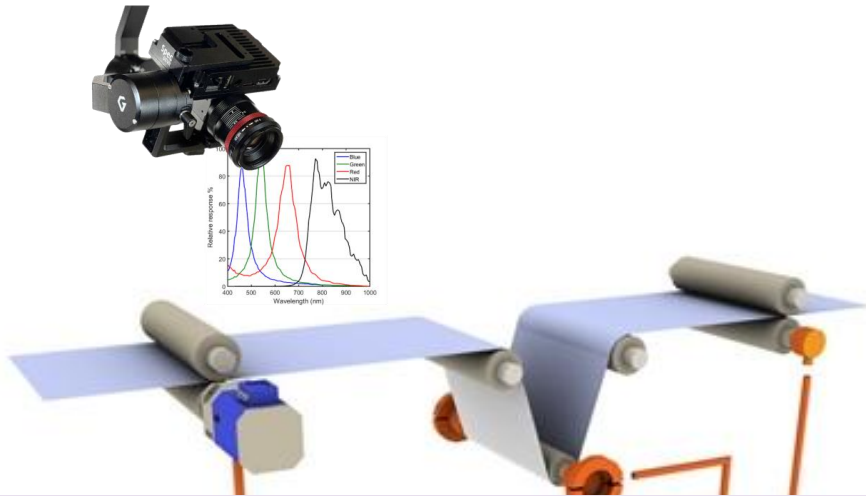


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THANK YOU!



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Questions?